

Search Notes**Application/Control No.**

10/688,139

Examiner

Y. J. Han

Applicant(s)/Patent under Reexamination

SCHIFF, TOD F.

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner
323	240		
	244		
	246		
	271		
	272		
	283		
	284		
	285		
	351		
363	10		
	41	4/05	9A

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
323	244		
	246		
	285	4/05	9A